


<b>Search Notes</b> 	<b>Application/Control No.</b>		<b>Applicant(s)/Patent under Reexamination</b>	
	10/771,636		ONODA ET AL.	
	<b>Examiner</b>		<b>Art Unit</b>	
	Tamai I.E. Karl		2834	

SEARCHED			
Class	Subclass	Date	Examiner
310	309		
359	223-226		
	290,291	1/12/2006	KIT
Update Search 9/22/06 kit			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR